

Notice of References Cited	Application/Control No. 10/566,218		Applicant(s)/Patent Under Reexamination YAMASHITA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0020764	02-2004	Andrews et al.	204/252
*	B	US-2001/0044042	11-2001	Inoue et al.	429/35
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO-01/71839	02-2001	International	Andrews et al.	
	O					
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	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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